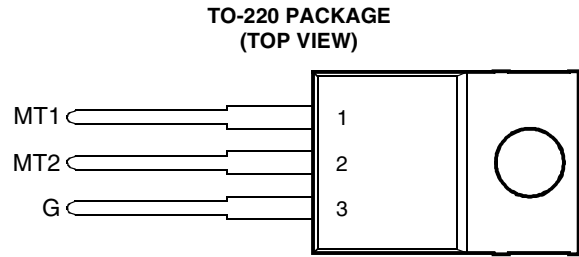


- Sensitive Gate Triacs
- 6 A RMS
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I_{GT} of 5 mA (Quadrants 1 - 3)



Pin 2 is in electrical contact with the mounting base.

MDC2ACA

absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING		SYMBOL	VALUE	UNIT
Repetitive peak off-state voltage (see Note 1)	TIC216D	V_{DRM}	400	V
	TIC216M		600	
	TIC216S		700	
	TIC216N		800	
Full-cycle RMS on-state current at (or below) 70°C case temperature (see Note 2)		$I_{T(RMS)}$	6	A
Peak on-state surge current full-sine-wave at (or below) 25°C case temperature (see Note 3)		I_{TSM}	60	A
Peak gate current		I_{GM}	±1	A
Peak gate power dissipation at (or below) 85°C case temperature (pulse width ≤ 200 μs)		P_{GM}	2.2	W
Average gate power dissipation at (or below) 85°C case temperature (see Note 4)		$P_{G(AV)}$	0.9	W
Operating case temperature range		T_C	-40 to +110	°C
Storage temperature range		T_{stg}	-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds		T_L	230	°C

- NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
 2. This value applies for 50-Hz full-sine-wave operation with resistive load. Above 70°C derate linearly to 110°C case temperature at the rate of 150 mA/°C.
 3. This value applies for one 50-Hz full-sine-wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.
 4. This value applies for a maximum averaging time of 20 ms.

electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
I_{DRM} Repetitive peak off-state current	$V_D = \text{rated } V_{DRM}$	$I_G = 0$	$T_C = 110^\circ\text{C}$			±2	mA
I_{GT} Gate trigger current	$V_{supply} = +12\text{ V}^\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$			5	mA
	$V_{supply} = +12\text{ V}^\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$			-5	
	$V_{supply} = -12\text{ V}^\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$			-5	
	$V_{supply} = -12\text{ V}^\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$			10	

† All voltages are with respect to Main Terminal 1.

PRODUCT INFORMATION

DECEMBER 1971 - REVISED SEPTEMBER 2002
 Specifications are subject to change without notice.

electrical characteristics at 25°C case temperature (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
V _{GT}	Gate trigger voltage	V _{supply} = +12 V†	R _L = 10 Ω	t _{p(g)} > 20 μs			2.2	V
		V _{supply} = +12 V†	R _L = 10 Ω	t _{p(g)} > 20 μs			-2.2	
		V _{supply} = -12 V†	R _L = 10 Ω	t _{p(g)} > 20 μs			-2.2	
		V _{supply} = -12 V†	R _L = 10 Ω	t _{p(g)} > 20 μs			3	
V _T	On-state voltage	I _T = ±8.4 A	I _G = 50 mA	(see Note 5)			±1.7	V
I _H	Holding current	V _{supply} = +12 V†	I _G = 0	Init' I _{TM} = 100 mA			30	mA
		V _{supply} = -12 V†	I _G = 0	Init' I _{TM} = -100 mA			-30	
I _L	Latching current	V _{supply} = +12 V†	(see Note 6)			4		mA
		V _{supply} = -12 V†				-2		
dv/dt	Critical rate of rise of off-state voltage	V _{DRM} = Rated V _{DRM}	I _G = 0	T _C = 110°C		±20		V/μs
dv/dt _(c)	Critical rise of commutation voltage	V _{DRM} = Rated V _{DRM}	I _{TRM} = ±8.4 A	T _C = 70°C	±2	±5		V/μs

† All voltages are with respect to Main Terminal 1.

NOTES: 5. This parameter must be measured using pulse techniques, t_p = ≤ 1 ms, duty cycle ≤ 2 %. Voltage-sensing contacts separate from the current carrying contacts are located within 3.2 mm from the device body.

6. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics:

R_G = 100 Ω, t_{p(g)} = 20 μs, t_r = ≤ 15 ns, f = 1 kHz.

thermal characteristics

PARAMETER		MIN	TYP	MAX	UNIT
R _{θJC}	Junction to case thermal resistance			2.5	°C/W
R _{θJA}	Junction to free air thermal resistance			62.5	°C/W